

**Search Notes****Application/Control No.**

10/708,826

**Examiner**

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**Applicant(s)/Patent under Reexamination**

BEENAU ET AL.

**Art Unit**

2635

**SEARCHED**

Class	Subclass	Date	Examiner
340	5.53	11/18/2005	NN
340	5.2	11/18/2005	NN
340	5.4+	11/18/2005	NN
340	5.52	11/18/2005	NN
340	5.6	11/18/2005	NN
340	5.8+	11/18/2005	NN
340	10.1	11/18/2005	NN
340	10.4-10.5	11/18/2005	NN
235	379	11/18/2005	NN
235	380	11/18/2005	NN
235	492	11/18/2005	NN
705	35,54,76	11/18/2005	NN
713	186	11/18/2005	NN
713	194	11/18/2005	NN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search East: USPAT; US-PUB; EPO; JPO AND DERWENT	11/18/2005	NN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner